

Notice of References Cited

Application/Control No.

10/550,902

Applicant(s)/Patent Under
Reexamination
OHYA ET AL.

Examiner

Patricia L. Hailey

Art Unit

1793

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*	B	US-5,071,517	12-1991	Oabayashi, Kiyoshi	205/158
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

